



Surface morphology and magnetic properties in $\text{Pr}_{0.7}\text{Sr}_{0.3}\text{MnO}_3$ layer grown on charge-ordered $\text{La}_{0.5}\text{Ca}_{0.5}\text{MnO}_3$ layer



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ABSTRACT

We report magnetic behaviors in $\text{Pr}_{0.7}\text{Sr}_{0.3}\text{MnO}_3$ (PSMO) layer grown on charge-ordered $\text{La}_{0.5}\text{Ca}_{0.5}\text{MnO}_3$ (LCMO) layer. PSMO/LCMO bilayer film was prepared by pulsed laser deposition on SrTiO_3 (001) substrate. Large particulates at the surface of PSMO layer impart inhomogeneous composition in film, resulting in the variation of film's crystalline structure. We find an exchange bias (EB) in the bilayer film with relative roughness and inhomogeneous surface, whereas smooth and homogeneous surface does not lead to an EB effect. It is believed that an antiferromagnetic structure is formed in the inhomogeneous PSMO layer, which causes the EB effect in this system. The present results are discussed and possible explanations are provided based on the random-field model of EB and the related research results.

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1. Introduction

A large variety of extraordinary properties have been discovered in oxide materials, such as colossal magnetoresistance (CMR) [1–3] in perovskite manganese oxides of composition $R_{1-x}A_x\text{MnO}_3$ (R = rare earth, A = alkaline earth) or high- T_C superconductivity [4]. CMR is often observed in a large range of doping x . For $0.2 < x < 0.45$, many compounds exhibit a ferromagnetic (FM) metallic phase below their Curie temperature T_C while presenting a semiconductor-like behavior in their paramagnetic phase at high temperature. The application of a magnetic field generates a magnetoresistance (MR) near this metal-insulator transition. Half-doped manganite $\text{La}_{0.5}\text{Ca}_{0.5}\text{MnO}_3$ (LCMO) [5] exhibits phase separated state and CO insulating state, which can turn into a metallic and FM phase via exerting magnetic field and introducing stress [6,7]. Due to recent improvement in thin-film deposition technique such as pulsed laser deposition (PLD), combining two materials with different properties in a system can lead to many interesting and novel effects [8–10]. The interfaces are complex especially when two competing ground states (the FM metallic state and the CO insulating state) are present [11]. Therefore, a FM $\text{Pr}_{0.7}\text{Sr}_{0.3}\text{MnO}_3$ (PSMO) layer grown on a CO LCMO layer to form FM/CO heterostructure should be appropriate for investigation.

The advanced thin film device often crucially depends on the microstructure such as surface morphology, interlayer roughness and growth

orientation. Surface and interface affect significantly the physical properties of manganite film. In this work, we study microstructure and magnetic properties of PSMO/LCMO. Our magnetic and structural measurements suggest a correlation between surface and interfacial structure and magnetic properties. We find an exchange bias (EB) effect, i.e., a shift of the hysteresis curves, in the bilayer film with relative inhomogeneous surface. Our study suggests that large particulates at surface can impart AFM structure to the FM PSMO layer and then induce the AFM/FM coupling leading, in turn, to the EB in this system.

2. Experimental details

Epitaxial PSMO (36 nm)/LCMO (24 nm) bilayer structure with PSMO as top layer was fabricated on single crystalline SrTiO_3 (STO) (001) substrate by pulsed laser deposition (PLD, Twente Solid State Technology BV) [12]. For the PLD growth, an excimer laser with 4.4×10^{-4} 248 nm, a repetition rate of 2 Hz, and an energy density of 3 J/cm² were used. The base pressure in the growth chamber was pumped to 2×10^{-5} mbar. During the deposition, the deposition temperature is 720 °C, the oxygen pressure is 5×10^{-1} mbar, and the deposition rate is ~ 2.4 Å/s for both materials. After deposition, the film was annealed in 1 atm pure oxygen for half an hour and cooled down slowly in the same oxygen pressure to avoid possible oxygen deficiency. Wavelength dispersive X-ray spectroscopy (LambdaSpec, EDAX Inc.) suggests that the composition of the PSMO and/or LCMO layer is the same as that of corresponding target within experimental error. Surface morphology was measured by atomic force microscopy (CSPM5500, Benyuan Nano Inc.) and the crystal structures were examined by high resolution X-ray diffraction (HRXRD). HRXRD diffraction experiments were

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performed at Beijing Synchrotron Radiation Facility (BSRF). The X-ray wavelength is 0.15405 nm and the energy resolution is 4.4×10^{-4} . Magnetic characterization was carried out in Physical Property Measurement System (PPMS-9T, Quantum Design Inc.) with a vibrating sample magnetometer (VSM) option.

3. Results and discussion

Fig. 1 shows room-temperature HRXRD in the θ - 2θ mode of PSMO/LCMO bilayer film. Besides the reflection from STO substrate, (002) diffraction peaks of PSMO layer and LCMO layer are visible, suggesting the epitaxial relationship between the two layers in relation to the substrate. The out-of-plane lattice parameter (a) and the corresponding strain (ε) of PSMO layer and LCMO layer can be calculated from the HRXRD curve (see Fig. 1). The out-of-plane strain ε can be calculated using the formula $\varepsilon = (a - a_0)/a_0$, where a_0 is the bulk unstressed lattice parameter as measured from power XRD pattern [12]. For PSMO, the out-of-plane strain value ($\varepsilon = -1.26\%$) shows slight out-of-plane compression of the PSMO lattice, indicating that PSMO layer has an in-plane tensile strain. In the same way, for LCMO, the out-of-plane strain value ($\varepsilon = -2.51\%$) suggests that LCMO layer has an in-plane tensile strain. Therefore, the bilayer film has an in-plane tensile strain. Interestingly, there exists a shoulder peak S1 (see Fig. 1). In inset of Fig. 1, we can see a smooth surface with root mean square (rms) roughness ~ 2.62 nm. The presence of large particulates (near top right-hand corner) in atomic force microscopy image represents an atomic collapse model [13]. The total volume fraction of the particulates is about 6.25%. Such surface large particulates are typically observed in PLD-deposited films and are usually related with non-stoichiometric deposition in island-growth film [14,15]. These large particulates at surface can impart inhomogeneous composition to the film, inducing the variation of crystalline structure (see peak S1).

Fig. 2 shows the zero field-cooling (ZFC) and field-cooling (FC) temperature-dependent magnetization measurements. A characteristic temperature $T^* \sim 54$ K is indicated with arrow in Fig. 2. Undesirable magnetization starts to decrease with further decrease of temperature at temperature T^* . This may be associated with the inhomogeneous magnetic phase induced by inhomogeneous composition in the bilayer film. Inhomogeneous composition has been shown to induce chemical or magnetic phase transition easily [16], which proves important role of inhomogeneities in determining magnetic properties. Moreover, anomaly magnetization with sharp decrease at 10 K under cooling field occurred. The large drop of magnetization in FC case probably

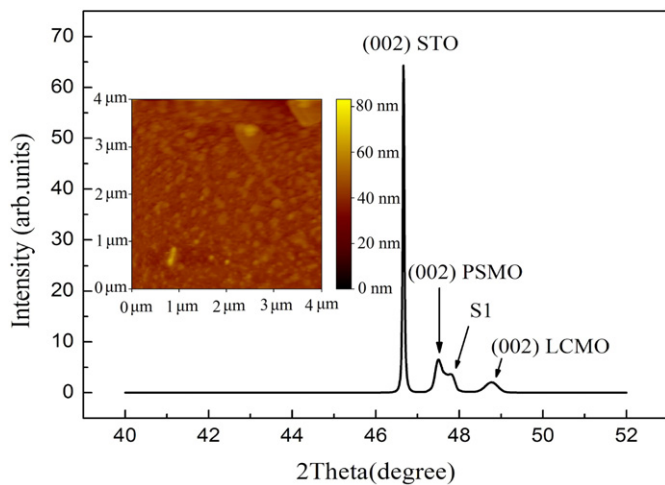


Fig. 1. HRXRD θ - 2θ scan centered on the STO (002) peak for PSMO/LCMO bilayer film on (001) STO substrate. Inset: atomic force microscopy contact mode image plotted for an area of $4 \times 4 \mu\text{m}^2$ of PSMO/LCMO film.

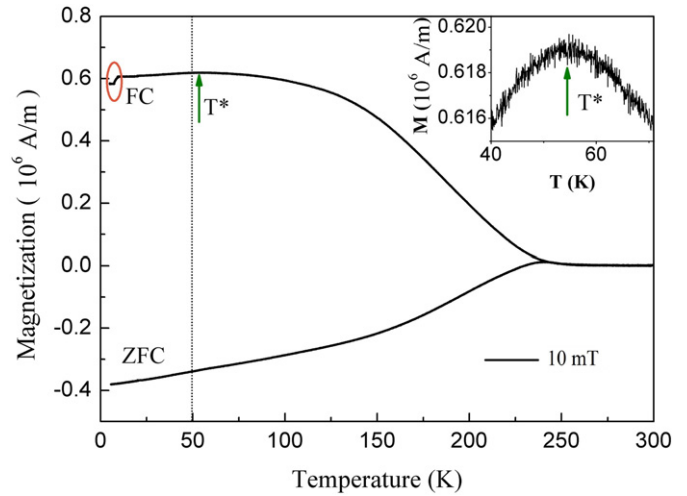


Fig. 2. Temperature dependence of magnetization with ZFC and FC in 10 mT field processes for PSMO/LCMO film. Inset was the enlarged magnetization curves.

correlates with thermal instability of a statistical distribution of magnetic domains in film.

Fig. 3 shows FC magnetic hysteresis loops, measured after cooling the film in 50 mT from 300 K down to 3 K, 50 K, 100 K and 200 K. Saturation magnetization (M_s) monotonously increases with decreasing temperature from 200 K. However, it starts to decrease slowly with further decreasing temperature at lower than 50 K. This temperature is coincident with T^* which is corresponding to the magnetization change in Fig. 2, confirming the important role of surface particulates in decreasing ferromagnetism.

Further, we measured the ZFC and FC hysteresis loops, measured after cooling the film without and with a 50 mT field from 300 K down to 3 K and 200 K. In Fig. 4(a), a small shift of the center of the hysteresis curve along the field axis at 3 K is observed after FC in 50 mT field. While for the ZFC process, the hysteresis is normal. The exchange bias field (H_{EB}) and coercive field (H_C) are defined as $H_{EB} = (|H_1| - |H_2|)/2$ and $H_C = (|H_1| + |H_2|)/2$, where H_1 and H_2 is the left and right coercive field, respectively. The H_{EB} of 7.8 mT and H_C of 28.6 mT are obtained at 3 K, whereas, the EB effect disappears at 200 K, as shown in Fig. 4(b). According to the random-field model of EB proposed by Malozemoff [17], $H_{EB} \propto \frac{f_j J}{2M_f d_{FM}^2}$, where M_f and d_{FM} is the magnetization

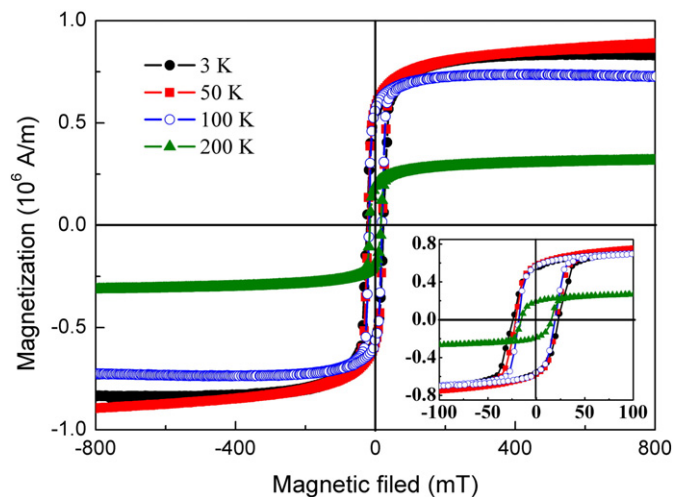


Fig. 3. The FC hysteresis loops of the PSMO/LCMO film at 3 K, 50 K, 100 K and 200 K. Inset shows low field magnetization behavior.

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